

CX11LHG AT CRYSTAL

16 MHz to 50 MHz

High Shock, Ultra Low Profile, Ultra-Miniature

AT Quartz Crystal

DESCRIPTION

CX11LHG is a high performance quartz crystal designed to survive the most extreme shock and high vibration application environments. Low acceleration sensitivity and low aging performance meets the most demanding requirements. Available with tight calibration tolerances and high stability over temperature.



- Mechanical shock survivability up to 75,000 g
- Ultra-low profile typical height of 0.5 mm
- Low acceleration sensitivity available
- Hermetically sealed ceramic package
- Excellent aging characteristics
- Full military testing available
- Designed, manufactured and tested in the USA

APPLICATIONS

Industrial & Communications

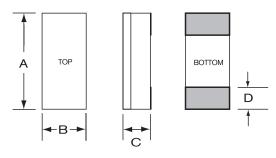
- Down-hole Data Recorder
- Process Control
- Environmental Control
- Engine Control
- Telemetry
- Ruggedized Instrumentation
- Automotive Control

Military & Aerospace

- Smart Munitions
- Timing Devices (Fuzes)
- Surveillance Devices
- Missile Telemetry
- Ruggedized Communications
- Aviation Equipment



PACKAGE DIMENSIONS

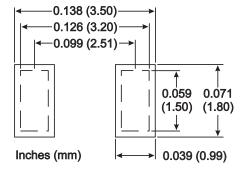


	TYPICAL		MAX	MAXIMUM	
DIM	inches	mm	inches	mm	
Α	0.127	3.20	0.135	3.43	
В	0.060	1.50	0.068	1.73	
С		see below	/		
D	0.028	0.71	0.037	0.94	

THICKNESS (DIM C)

Termination	Typical		Maximum		
	inches	mm	inches	mm	
SM1	0.020	0.51	0.023	0.59	
SM2/SM4	0.021	0.53	0.024	0.60	
SM3/SM5	0.023	0.58	0.025	0.63	

SUGGESTED LAND PATTERN



10193 Rev A







SPECIFICATIONS

Specifications are typical at 25°C unless otherwise noted. Spe-cifications are subject to change without notice.

Fundamental Frequency ¹		24.0 MHz		
Motional Resistance $R_1(\Omega)$	85	30	25	
Motional Capacitance C ₁ (fF) 1.5	1.6	1.9	
Quality Factor Q (k)	80	150	110	
Shunt Capacitance C ₀ (pF)	0.7	0.7	0.9	
Calibration Tolerance ²	± 100 to ± 30 ppm, or tighter as required			
Load Capacitance	10 pF (unle	ss specified o	otherwise)	
Drive Level	200 μW MA	λX		
Frequency-Temperature	±50 ppm to ±10 ppm (Commercial)			
Stability ^{2,3}	±50 ppm to ±20 ppm (Industrial)			
	±100 ppm	to ±30 ppm ((Military)	
Aging, first year	5 ppm MAX	(
Shock, survival	up to 75,00	00 g, 0.3 ms,	1/2 sine	
Vibration, survival ⁴	20 g, 10-2,	000 Hz swep	ot sine	
Operating Temp. Range		70°C (Comn		
		35°C (Indust	•	
	-55°C to +1	125°C (Militar	y)	
Storage Temp. Range	-55°C to +1	125°C		
Max Process Temperature	260°C for 2	20 sec.		

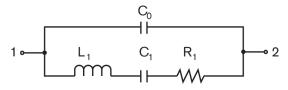
- 1. For frequencies above 50 MHz contact factory.
- 2. Other tolerances available. Contact factory.
- 3. Does not include calibration tolerance. The characteristics of the frequency stability over temperature follow that of the AT thickness-shear mode.
- 4. Per MIL-STD-202G, Method 204D, Condition D. Random vibration testing also available.

TERMINATIONS

<u>Designation</u>	<u>Termination</u>
SM1	Gold Plated
SM2	Solder Plated
SM3	Solder Dipped
SM4	Solder Plated (Lead Free)
SM5	Solder Dipped (Lead Free)

Max Process Temperature 260°C for 20 sec.

EQUIVALENT CIRCUIT



R₁ Motional Resistance L₁ Motional Inductance C₁ Motional Capacitance C₀ Shunt Capacitance

PACKAGING OPTIONS

- Tray Pack
- 12 mm tape, 7"or 13" reels Per EIA 481 (see Tape and Reel data sheet 10109)

HOW TO ORDER LOW PROFILE CX11LHG AT CRYSTALS

